

Notice of References Cited	Application/Control No. 10/535,210	Applicant(s)/Patent Under Reexamination MARUYAMA ET AL.	
	Examiner Karuna P. Reddy	Art Unit 1713	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0050364 A1	03-2003	Sato et al.	523/160
	B	US-			
	C	US-			
	D	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*	O	WO 200177198 A1	10-2001	World Intellect	BERGE et al.	
	P					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	X	

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